

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 216450US0DIV		SERIAL NO. NEW APPLICATION	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Kenichi HINO			
				FILING DATE HEREWITH			
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>P.S.</i>	AA	5,264,513	11/23/93	Kunio IKEMURA, et al.			
<i>P.S.</i>	AB	4,719,149	01/12/88	Steven M. AASEN, et al.			
<i>P.S.</i>	AC	6,051,626	04/18/00	W. ZENG, et al.			
<i>P.S.</i>	AD	5,525,648	06/11/96	Steven M. AASEN, et al.			
<i>P.S.</i>	AE	5,321,053	06/14/94	HINO, et al.			
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
<i>P.S.</i>	AO	WO 93/12760	07/08/93	WIPO (with corr. US 5,525,648)			
<i>P.S.</i>	AP	0 835 646	04/15/98	EUROPE (with corr. US 6,051,626)			
<i>P.S.</i>	AQ	2 332 911	07/07/99	GREAT BRITAIN			
<i>P.S.</i>	AR	3-240712	10/28/91	JAPAN (w/English Abstract)			x
<i>P.S.</i>	AS	62-223289	10/01/87	JAPAN (w/English Abstract)			x
<i>P.S.</i>	AT	60-45510	03/12/85	JAPAN (w/English Abstract)			x
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						
Examiner <i>Peter J. Kelly</i>					Date Considered <i>2/23/04</i>		
<small>*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>							

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